# Samsung e·MMC Product family

e.MMC 4.41 Specification compatibility

# datasheet

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# **Revision History**

Revision No.	<u>History</u>	Draft Date	<u>Remark</u>	<u>Editor</u>
0.5	1. Engineering Sample	Apr. 05, 2012	Preliminary	S.M.Lee
1.0	<ol> <li>Customer Sample</li> <li>Information of Wear Leveling is deleted in Chapter 5.1.4</li> <li>Information of 'End of Life Management' is deleted in Chapter 5.1.7</li> <li>Information of Smart Report is deleted in Chapter 5.2</li> <li>Performance is updated with measured value in Table 28</li> <li>Extended CSD Register value is changed in Chapter 6.4         <ul> <li>AUTO_BKOPS is changed to "Don't care"</li> </ul> </li> <li>Time Parameter is changed in Chapter 7.1         <ul> <li>Write Timeout is changed in Table 34</li> </ul> </li> <li>Power Measurement conditions are changed in Chapter 8.0</li> </ol>	Jun. 08, 2012	Final	S.M.Lee
1.1	<ol> <li>4,8,16GB products are added</li> <li>CSD Register value is changed in Chapter 6.3         <ul> <li>R2W_FACTOR is changed to 0x03</li> </ul> </li> <li>Time Parameter is changed in Chapter 7.1         <ul> <li>Write Timeout is changed to 350ms</li> </ul> </li> <li>Standby Power Consumption of NAND is changed in Table 44</li> </ol>	Jul. 9, 2012	Final	S.M.Lee



Unit

# Revision History Appendix (1.0)

	Before(ver.0	.5)	After(ver.1.0)						
[Table 28] Perfo	ormance		Table 28  Performance						
Density	Sequential Read (MB/s)	Sequential Write (MB/s)	Density	Sequential Read (MB/s)	Sequential Write (MB/s)				
32 GB	95	22	32 GB	74	20				
64 GB	30	22	64 GB	√ 1					
* Test/ Estimation	on Condition : Bus width x 8, 52M Hz DDR, 4	MB data transfer, w/o file system overhead	* Test Condition : Bu	s width x8, 50MHz DDR, 512KB data transfer, w/o file sj	stem overhead, measured on Samsung's internal board				

Table 341 Time Parameter

[ lable 34] Time Parameter							
Timing P	Max. Value	Unit					
Initialization Time (tINIT)	Normal <sup>1)</sup>	1	s				
escarata parace e temp (secces).	After partition setting 2)	ø	v				
Read Timeout		100	ms				
Write Timeout		350(TBD)	ms				
Erase Timeout		15	ms				
Force Erase Timeout		3	min				
Secure Erase Timeout		<b>∞</b>	vi				
Secure Trim step1 Timeou	t	5	s				
Secure Trim step2 Timeou	it	3	s				
Trim Timeout <sup>3)</sup>		600	ms				
Partition Switching Timeo	Partition Switching Timeout (after Init)						
Power Off Notification Tim	600	ms					
Discard Timeout	15	ms					

Table	341	Time	Para	mete

(lable 3+) Time Parameter								
Timing P	Max. Value	Unit						
Joitialization Time (tINIT)	Normal <sup>1)</sup>	1	s					
oscinger property is the factors of	After partition setting 2)	3	s					
Read Timeout		100	ms					
Write Timeout	:	700	ms					
Erase Timeout		15	ms					
Force Erase Timeout		3	min					
Secure Erase Timeout	:	8	s					
Secure Trim step1 Timeou	t	5	s					
Secure Trim step2 Timeou	at	3	s					
Trim Timeout 3)		600	ms					
Partition Switching Timeo	100	us						
Power Off Notification Tim	eout	600	ms					
Discard Timeout		15	ms					

[Table 33] Extended CSD Register

Name	Field	Size (Bytes)	Cell Type	CSD-slice	CSD 32GB	Value 64GB
Vendor Config (Auto Background Operation)	AUTO_BKOPS	1	R/W/E	[67]	0x	00

[Table 33] Extended CSD Register

NAND Type

Name	Field	Size	Cell	CSD-slice	CSD Value		
1101110	11010	(Bytes)	Type	C3D 61108	32GB	64GB	
Vendor Config (Auto Background Operation)	AUTO_BKOPS	1	R/W/E	[67]	Don't Care		

8.2 Standby Power Consumption in auto power saving mode and standby state

1	Den sity	NAND Type	СТ	RL	N/	Unit		
1	Daibay	titulo type	25°C (Typ)	85°C	25°C(Typ)	85°C	-	
3	32GB	64Gb TLC x 4	400	260	60	200		
1	64GB	64Gb TLC x 8	109	263	120	400	200	

NOTE:
Sower Measurement conditions: Bus configuration = x8 @ 52MHz , No CLK
"Typical value is measured at Vco=3.3V, TA=25°C. Not 100% tested.

8.3 Sleep Power Consumption in Sleep State

Doneite	NAND Type	ст	RL	NAND	Unit
Daibay	titulo type	25°C (Typ)	85°C		
32GB	64Gb TLC x 4	100	250	21)	
64GB	64Gb TLC x 8	100	203		

8.3 Sleep Power Consumption in Sleep State

- Densite

able 44] Sieep Power Consumption in Sieep State										
Donaite	NAND Type	СТ	RL	NAND	Unit					
Daisiy	шигриурс	25°C (Typ)	85°C		D.K.L					
32GB	64Gb TLC x 4	100	250	21)						
64GB	64Gb TLC x 8	103	200	3						

NOTE:

NO

8.2 Standby Power Consumption in auto power saving mode and standby state

rower Measurement conditions. Bus configuration =x6.@ 50MHz.
I) it auto power saving mode. NAND power can not be turned off. However in sleep mode NAND power can be turned off. If NAND power is alive. NAND power same with that of the Sarindystate.



# Revision History Appendix (1.1)

			Befo	re(ve	.1.0)								Afte	er(ve	er.1.1)				
									[Table 1] Product List										
[Table 1] Product L									Capacities e-Mi	MC Part ID	NAN	D Flash Type	User Densi	ity (%)	Power System	ı P	ackage size	Pin C	onfiguration
			pe User Densi		Power System			Pin Configuration	4GB KLM 4G	1YE4C-800	01 32	GbTLC x 1			··· (ntorface power ··	11.5mn	m x 13mm x 1.0r	am 1	153FBGA
32GB KLM	IBG4WE4A-A001	64GbTLC x	4		nterface power (1:70V ~ 1:95V		1 x 1.0mm		BGB KLM8G	1WE4A-A0	01 64	GbTLC x 1		· · · · · ·	(1.70V ~ 1.95V			$\top$	
			91.09	5	2.7V ~ 3.6V	)		169FBGA	16GB KLMAG	2WE4A-A0	01 64	GbTLC x 2	91.0%	6	2.7V ~ 3.6V)	12mm	x 16mm x 1.0m	m ,	69FBGA
64GB KLM	1CG8WE4A-A001	64GbTLC x	8	- M	emory power: (2.7V ~ 3.6V		1 x 1.2mm		32GB KLMBG	4WE4A-A0	01 64	GbTLC x 4			**Memory **power **\(2.7V. ~.3.6V.)				
					(2.74 ~ 3.04	,			64GB KLMCG	8WE4A-A0	01 64	GbTLC x 8				12mm	x 16mm x 1.2m	m	
									aa. aa										
[Table 32]	] CSD Reg	ister							[Table 33] CS	iD Regis	ster								
		_	-1-1	100 -161	Cell	000 -11	CSI	D Value	Name		E	ield	Width	Cell	CSD slice		C SD Va	lue	
Pla	ımə	<del>-</del> 1	eld	Widt	Туре	CSD-slice	32GI	B 64GB				.014		Type	0000000	4GB 80	GB 16GB	32G E	3 64GB
									Write speed	footor	D OW	FACTOR	3	В	100.001		0x03	_	
Write spe	eed factor	R2W_F	ACTOR	3	R	[28:26]		0x02	write speed	ractor	KZW_	FACTOR	3	R	[28:26]		UXUS	1	
				-		-	-						' '		1			<u> </u>	
[Table 34] Time Par	arameter								[Table 35] Time Para		ning Para	amter			M	ax, Value		- 0	nit
	T	iming Paramte	er .			Max. Value		Unit								1			s
		Norr	nal 1)			1		5	Initialization Time (tl	NIT)	No	ormal <sup>1)</sup>			(300	ms for 4GB)			
-Initialization-Time	(858T)	After	partition setting	2)		3		ŝ			Aft	ter partition sett	ing <sup>2)</sup>			3		- (	ş
Read Timeout			,			100		ms	Read Timeout							100		p	ns
Write Timeout						700		ms	Write Timeout							350		n	ms
Erase Timeout						15		ms	Erase Timeout			15			P	ns			
Force Erase Time	out					3		min	Force Erase Time ou	ıt					3			п	nin
Secure Erase Tim	neout					8		s	Secure Erase Timed	out						8		8	
Secure Trim step1	1 Timeout					5		s	Secure Trim step1 T	imeout						5		5	
Secure Trim step2						3		s	Secure Trim step2 T	imeout					3				5
Trim Timeout 3)						600		ms	Trim Timeout 3)						600			n	ms
	g Timeout (after Init)					100		us	Partition Switching 1	Time out (afte	er Init)				100				JS
Power Off Notifica						600		ms	Power Off Notification	on Timeout 4	9				600			P	ms
Discard Timeout						15		ms	Discard Timeout		-			_	15			ms	
2) Initialization Time a 3) If 8KB Size and Ad	on Time without partition after partition setting, re address are aligned, M ax	efer to INI_TIME 0 c. Timeout value i	s 300ms		ower savi	ing mode and	standhy	, state	NOTE: 1) Normal Initialization T 2) Initialization Time ate 3) If 8KB Size and Addm 4) Power 0 ff Notification [Table 44] Standby Po	er partition set ess are aligne is not implem	ting, refer t ed, M ax. Tin n ented for	to INI_TIME OUT_ meout value is 30 4,8GB products	Dms	nd standt					
[rable left	otarraby r on	101 00110	dinpaon a					Ottato	Density		AND Typ			CTRL			NAND		Unit
D16				CTRL		NAN	D	11					25°C(Typ)		85°C	25°C (Typ)	85	c	
Density	NANI	Jiype	25°C(	Typ)	85°C	25°C(Typ)	85%	Unit	4GB 8GB		GbTLC:					40	85	j	
									16GB		IGB TLC :		100		250	50	13		шА
4GB	32Gb 7	ΓLC x 1	10	0	250	50	85	uA	32GB		IGB TLC :		100		250	70	23		uA.
Table 431 Standby	Power Consumption	n in auto nower	s aving mode and	i standhy sta	to				52GB 64GB		IGB TLC :					130	43		
			July mode one	CTRL		NAND			0400	04	OU IEC					130	45		
Density	NAND:	Гуре	25°C(Typ)	_	5°C	25°C(Typ)	85°C	Unit											
8GB	64Gb TL	C x 1				50	85												
16GB	64Gb TL		100	};	260	55 (TBD) 1	135 (TBD)	Au											
1	Power Consumption		r saving mode a	nd standby s	tate	,		1											
				CTRL		NAND	)												
Density	HAND	Туре	25℃(Typ)		85°C	25°C (Typ)	85°C	Unit											
32GB	64GbT	LC x 4				60	200												
64GB	64GbT		100		-250	120	400												
	2.001								1										

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## **INTRODUCTION**

The SAMSUNG e·MMC is an embedded MMC solution designed in a BGA package form. e·MMC operation is identical to a MMC card and therefore is a simple read and write to memory using MMC protocol v4.41 which is a industry standard.

e·MMC consists of NAND flash and a MMC controller. 3V supply voltage is required for the NAND area (VDDF) whereas 1.8V or 3V dual supply voltage (VDD) is supported for the MMC controller. Maximum MMC interface frequency of 52MHz and maximum bus widths of 8 bit are supported.

There are several advantages of using e-MMC. It is easy to use as the MMC interface allows easy integration with any microprocessor with MMC host. Any revision or amendment of NAND is invisible to the host as the embedded MMC controller insulates NAND technology from the host. This leads to faster product development as well as faster times to market.

The embedded flash mangement software or FTL(Flash Transition Layer) of e·MMC manages Wear Leveling, Bad Block Management and ECC. The FTL supports all features of the Samsung NAND flash and achieves optimal performance.

# 1.0 PRODUCT LIST

[Table 1] Product List

Capacities	e-MMC Part ID	NAND Flash Type	User Density (%)	Power System	Package size	Pin Configuration
4GB	KLM4G1YE4C-B001	32Gb TLC x 1		- Interface power : VDD	11.5mm x 13mm x 1.0mm	153FBGA
8GB	KLM8G1WE4A-A001	64Gb TLC x 1		(1.70V ~ 1.95V or		
16GB	KLMAG2WE4A-A001	64Gb TLC x 2	91.0%	2.7V ~ 3.6V)	12mm x 16mm x 1.0mm	169FBGA
32GB	KLMBG4WE4A-A001	64Gb TLC x 4		- Memory power : VDDF (2.7V ~ 3.6V)		1001 BOA
64GB	KLMCG8WE4A-A001	64Gb TLC x 8		(2.7 * 0.0 *)	12mm x 16mm x 1.2mm	

# 2.0 KEY FEATURES

- MultiMediaCard System Specification Ver. 4.41 compatible. Detail description is referenced by JEDEC Standard
- SAMSUNG e·MMC supports below special features which are being discussed in JEDEC
  - High Priority Interrupt scheme is supported
  - Back ground operation is supported.
- Full backward compatibility with previous MultiMediaCard system ( 1bit data bus, multi-e·MMC systems)
- Data bus sidth :1bit(Default), 4bit and 8bit
- MMC I/F Clock Frequency : 0  $\sim$  52MHz MMC I/F Boot Frequency : 0  $\sim$  52MHz
- Dual Data Rate mode is supported
- $\bullet$  Temperature : Operation(-25°C ~ 85°C), Storage without operation (-40°C ~ 85°C)
- $\bullet \ \text{Power} \ : \text{Interface power} \ \rightarrow \ \text{VDD} \ (1.70 \text{V} \ \sim 1.95 \text{V or} \ 2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{Memory power} \ \rightarrow \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{Memory power} \ \rightarrow \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{Memory power} \ \rightarrow \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{Memory power} \ \rightarrow \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{Memory power} \ \rightarrow \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{Memory power} \ \rightarrow \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{Memory power} \ \rightarrow \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{Memory power} \ \rightarrow \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{Memory power} \ \rightarrow \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{Memory power} \ \rightarrow \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{Memory power} \ \rightarrow \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{Memory power} \ \rightarrow \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{Memory power} \ \rightarrow \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{Memory power} \ \rightarrow \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{Memory power} \ \rightarrow \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{Memory power} \ \rightarrow \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{Memory power} \ \rightarrow \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{Memory power} \ \rightarrow \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{Memory power} \ \rightarrow \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{Memory power} \ \rightarrow \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{Memory power} \ \rightarrow \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{Memory power} \ \rightarrow \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{VDDF} (2.7 \text{V} \ \sim 3.6 \text{V}) \ , \ \ \text{V$



# 3.0 PACKAGE CONFIGURATIONS

# 3.1 153 Ball Pin Configuration

[Table 2] 153 Ball Information

Name
DAT0
DAT1
DAT2
DAT3
DAT4
DAT5
DAT6
DAT7
RSTN
VDD
VDDF
VDDF
VDDF
VDDF
VDDI
CMD
CLK
VSS

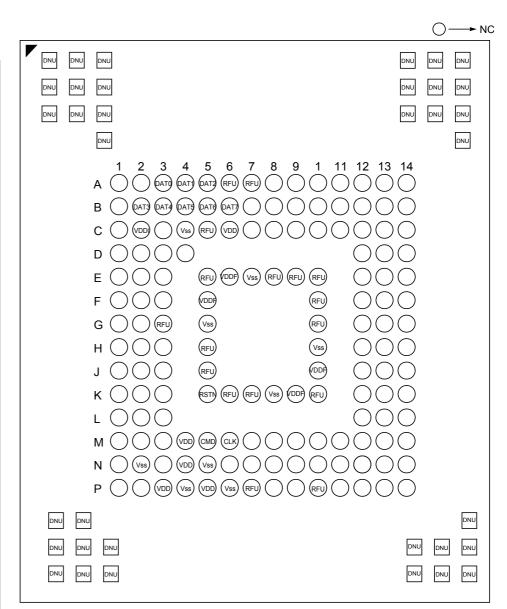


Figure 1. 153-FBGA



# 3.2 169 Ball Pin Configuration

[Table 3]	169 Ball	Information
-----------	----------	-------------

Pin NO	Name	Pin NO	Name
K6	VDD	AA5	VDD
T10	VDDF	W4	VDD
K2	VDDI	Y4	VDD
R10	Vss	AA3	VDD
W5	CMD	U9	VDDF
W6	CLK	M6	VDDF
H3	DAT0	N5	VDDF
H4	DAT1	U8	Vss
H5	DAT2	M7	Vss
J2	DAT3	AA6	Vss
J3	DAT4	P5	Vss
J4	DAT5	Y5	Vss
J5	DAT6	K4	Vss
J6	DAT7	Y2	Vss
H6	RFU	AA4	Vss
H7	RFU	U5	RSTN
K5	RFU		
M5	RFU		
M8	RFU		
M9	RFU		
M10	RFU		
N10	RFU		
P3	RFU		
P10	RFU		
R5	RFU		
T5	RFU		
U6	RFU		
U7	RFU		
U10	RFU		
AA7	RFU		
AA10	RFU		

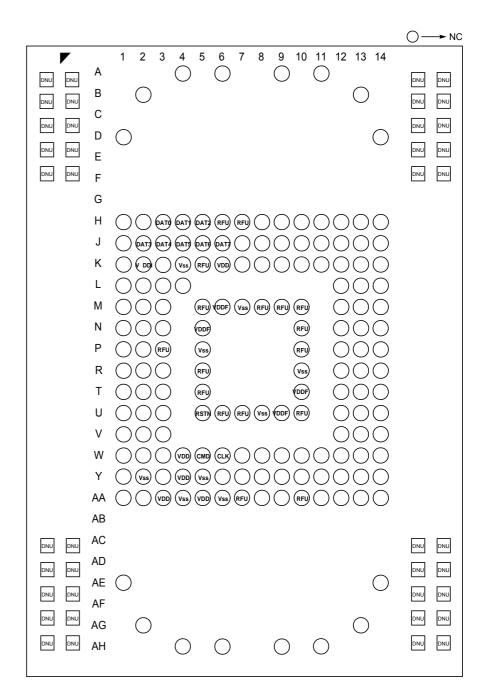


Figure 2. 169-FBGA



## 3.2.1 11.5mm x 13mm x 1.0mm Package Dimension

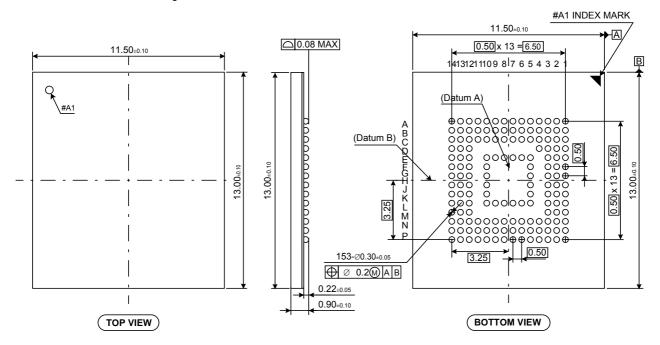


Figure 3. 11.5mm x 13mm x 1.0mm Package Dimension

### 3.2.2 12mm x 16mm x 1.0mm Package Dimension

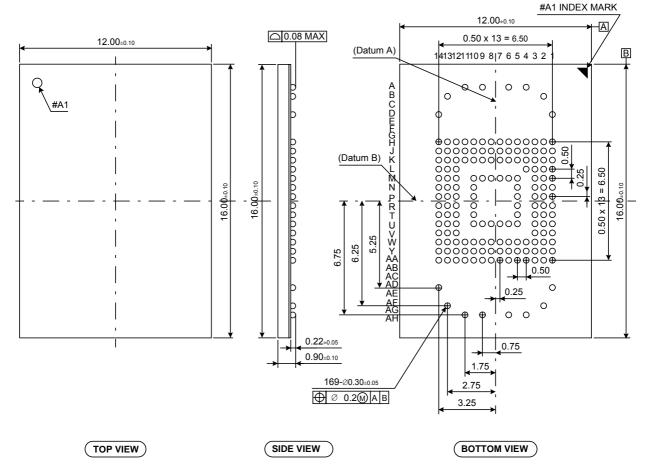


Figure 4. 12mm x 16mm x 1.0mm Package Dimension



## 3.2.3 12mm x 16mm x 1.2mm Package Dimension

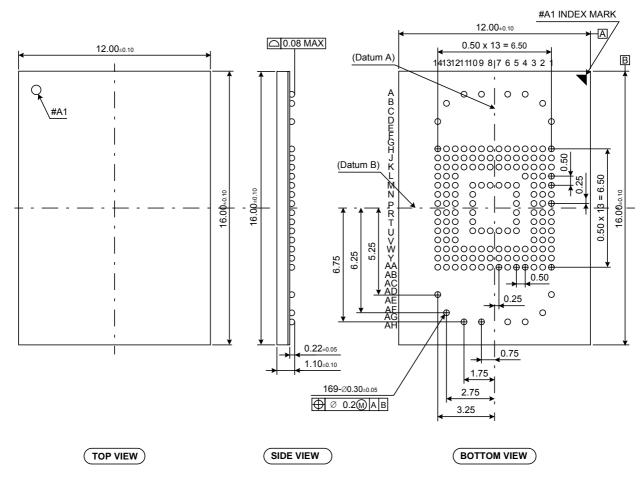


Figure 5. 12mm x 16mm x 1.2mm Package Dimension

# 3.3 Product Architecture

- e·MMC consists of NAND Flash and Controller. VDD is for Controller power and VDDF is for flash power

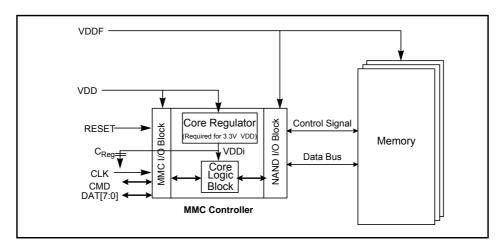


Figure 6. e-MMC Block Diagram

# 4.0 e.MMC 4.41 features

## 4.1 Data Write

Host can configure reliability mode to protect existing data per each partition.

This relibility mode has to be set before partitioning is completed.

This reliability setting only impacts the reliability of the main user area and the general purpose partitions.

[Table 4] EXT\_CSD value for reliability setting in write operation

Name	Field	Size (Bytes)	Cell Type	EXT_CSD-slice	Value
Data Reliability Configuration	WR_REL_SET	1	R/W	[167]	0x1F
Data Reliability Supports	WR_REL_PARAM	1	R	[166]	0x05

Explanation of each field in the upper table is mentioned below

[Table 5] Definition of EXT\_CSD value for reliability setting

Fields	Definitions		
I HS CIRL REL	0x0: All the WR_DATA_REL parameters in the WR_REL_SET registers are read only bits. 0x1: All the WR_DATA_REL parameters in the WR_REL_SET registers are R/W.		
	0x0: The device supports the previous definition of reliable write. 0x1: The device supports the enhanced definition of reliable write		

The below table shows each field for WE\_REL\_SET

[Table 6] Description of each field for WE\_REL\_SET

Name	Field	Bit	Size	Туре
Write Data Reliability (user Area)	WR_DATA_REL_USR	0	1	R (if HS_CTRL_REL=0) R/W (if HS_CTRL_REL=1)
Write Data Reliability Partition 1	WR_DATA_REL_1	1	1	R (if HS_CTRL_REL=0) R/W (if HS_CTRL_REL=1)
Write Data Reliability Partition 2	WR_DATA_REL_2	2	1	R (if HS_CTRL_REL=0) R/W (if HS_CTRL_REL=1)
Write Data Reliability Partition 3	WR_DATA_REL_3	3	1	R (if HS_CTRL_REL=0) R/W (if HS_CTRL_REL=1)
Write Data Reliability Partition 4	WR_DATA_REL_4	4	1	R (if HS_CTRL_REL=0) R/W (if HS_CTRL_REL=1)
Reserved	-	7:5	-	-



## 4.2 Reliable Write

[Table 7] EXT\_CSD value for reliable write

Name	Field	Size (Bytes)	Cell Type	CSD-slice	Value
Data Reliability Supports	WR_REL_PARAM	1	R	[166]	0x05

Reliable write with EN REL WR is 0x1 supports atomicity of sector unit.

The block size defined by SET\_BLOCKLEN (CMD16) is ignored and reliable write is executed as only 512 byte length. There is no limit on the size of the reliable write.

[Table 8] EXT\_CSD value for reliable write

Name	Field	Size (Bytes)	Cell Type	CSD-slice	Value
Reliable Write Sector Count	REL_WR_SEC_C	1	R	[222]	0x01

## 4.3 Secure Trim

Secure Trim operation consists of Secure Trim Step1 and Secure Trim Step2.

In Secure Trim Step 1 the host defines the range of write blocks that it would like to mark for the secure purge.

[Table 9] EXT\_CSD value for secure trim

Field	Definitions	Value
SEC_TRIM_MULT	Secure Trim Step2 Timeout = 300ms x ERASE_TIMEOUT_MULT x SEC_TRIM_MULT	0x11

Area marked by Secure Trim Step1 is shown as EXT\_CSD[181](ERASED\_MEM\_CONT) before Secure Trim Step2 is completed.

When Secure Trim Step2 is issued, if there is no data marked by Secure Trim Step1, Secure Trim Step2 does not work.

# 4.4 High Priority Interrupt

High Priority Interrupt is to stop ongoing operation and perform read operation with high priority

Command set for High Priority Interrupt operation is the below

[Table 10] Command List for High Priority Interrupt

CMD Index	Туре	Argument	Resp	Abbreviation	Command Description
CMD12	ac	[31:16] – RCA* [15:1] – stuff bits [0] – High Priority Interrupt * *To be used only to send a High Priority Interrupt	R1b	STOP_TRANSMISSION	If High Priority Interrupt flag is set the device shall interrupt its internal operations in a well defined timing

Interruptible commands by read while write operation are the below.

[Table 11] List of Interruptible Command

Commands	Names	Notes
CMD24	WRITE SINGLE BLOCK	-
CMD25	WRITE MULTIPLE BLOCKS	-
CMD25	RELIABLE WRITE	Stopping a reliable write command with 'High Priority Interrupt' flag set turns that command into a reliable write command
	ERASE	-
CMD38	TRIM	-
CIVIDO	SECURE ERASE	-
	SECURE TRIM	-
CMD6	SWITCH	BACKGROUND OPERATION ONLY



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# KLMxGxxE4x-x001

## [Table 12] EXT\_CSD value for HPI

Name	Field	Size(Bytes)	Cell Type	CSD-Slice	Value
HPI features	HPI_FEATURES	1	R	[503]	0x03
Number of correctiy programmed sectors	CORRECTLY_PRG_SECTORS_NUM	4	R	[245:242]	0x00
Partition switching timing	PARTITION_SWITCH_TIME	1	R	[199]	0x01
Out of interrupt busytiming	OUT_OF_INTERRUPT_TIME	1	R	[198]	0x02
HPI management	HPI_MGMT	1	R/W/E_P	[161]	0x00

## [Table 13] Definition of EXT\_CSD value for HPI

Fields	Definitions
HPI_FEATURES	Bit 0 means HPI_SUPPORT Bit 0 = 0x0 : High Priority Interrupt mechanism not supported Bit 0 = 0x1 : High Priority Interrupt mechanism supported  Bit 1 means HPI_IMPLEMENTATION 0x0 : HPI mechanism implementation based on CMD13 0x1 : HPI mechanism implementation based on CMD12
CORRECTLY_PRG_SECTOR_NUM	This field indicates how many 512B sectors were successfully programmed by the last WRITE_MULTIPLE_BLOCK command (CMD25).  CORRECTLY_PRG_SECTORS_NUM=EXT_CSD[242]*2^0+EXT_CSD[243]*2^8 +EXT_CSD[244]*2^16 + EXT_CSD[245]*2^24
PARTITION_SWITCH_TIME	This field indicates the maximum timeout for the SWITCH command (CMD6) when switching partitions by changing PARTITION_ACCESS bits in PARTITION_CONFIG field (EXT_CSD byte [179]).  Time is expressed in units of 10 milliseconds
OUT_OF_INTERRUPT_TIME	This field indicates the maximum timeout to close a command interrupted by HPI - time between the end bit of CMD12 / CMD 13 to the DAT0 release by the device.
HPI_MGMT	Bit 0 means HPI_EN 0x0 : HPI mechanism not activated by the host 0x1 : HPI mechanism activated by the host



# 4.5 Background Operation

When the host is not being serviced, e·MMC can do internal operation by using "Background Operation" command. In this operation which takes long time to complete can be handled later when host ensure enough idle time (In Back ground operation)

Background Operation Sequence is the following

## [Table 14] Background Operation Sequence

Function	Command	Description
Background Operation Check	CMD8 Or Card Status Register	If BKOPS_STATUS is not 0 or 6 <sup>th</sup> bit of card status register is set, there are something to be performed by background operation
Background Operation Start	CMD6	Background operation starts by BKOPS_START is set to any value. When background operation is completed BKOPS_STATUS is set to 0 and BKOPS_START is set to 0.
Background Operation Stop	НРІ	If the background operation is stopped BKOPS_START is set to 0

### [Table 15] EXT\_CSD value for Background Operation

Name	Field	Size(Bytes)	Cell Type	CSD-Slice	Value
Background operations Support	BKOPS_SUPPORT	1	R	[502]	0x01
Background operations status	BKOPS_STATUS	1	R	[246]	0x00
Manually start background operations	BKOPS_START	1	W/E_P	[164]	0x00
Enable background operations hand shake	BKOP_EN	1	R/W	[163]	0x00

### [Table 16] Definition of EXT\_CSD value for Bakgrourd Operation

Fields	Definitions
BKOPS_SUPPORT	'0' means Background operation is not supported '1' means Background operation is supported
BKOPS_STATUS	'0' means No background work pending '1' means pending background work existing. '2' means pending background work existing & performance being impacted. '3' means pending background work existing & critical
BKOPS_START	Background operation start while BKOPS_START is set to any value.  '0' means Background operation is enabled.
BKOPS_EN	'0' means host does not support background operation '1' means host use background operation manually

## [Table 17] Card Status Register for Background Operation

Bits	Identifier	Туре	Det Mode	Value	Description	Clear Cond
6	URGENT_BKOPS	S	R	"0" = Not Urgent "1" = Urgent	If set, device needs to perform background operations urgently. Host can check EXT_CSD field BKOPS_STATUS for the detailed level (in case of BKOPS_STATUS is 2 or 3)	А



# 5.0 Technical Notes

# 5.1 S/W Agorithm

### 5.1.1 Partition Management

The device initially consists of two Boot Partitions and RPMB Partition and User Data Area.

The User Data Area can be divided into four General Purpose Area Partitions and User Data Area partition. Each of the General Purpose Area partitions and a section of User Data Area partition can be configured as enhanced partition.

#### 5.1.1.1 Boot Area Partition and RPMB Area Partition

Default size of each Boot Area Partition is 2,048KB and can be changed by Vendor Command as multiple of 512KB. Default size of RPMB Area Partition is 128 KB and can be changed by Vendor Command as multiple of 128KB.

Boot Partition size & RPMB Partition Size are set by the following command sequence :

[Table 18] Setting sequence of Boot Area Partition size and RPMB Area Partition size

Function	Command	Description
Partition Size Change Mode	CMD62(0xEFAC62EC)	Enter the Partition Size Change Mode
Partition Size Set Mode	CMD62(0x00CBAEA7)	Partition Size setting mode
Set Boot Partition Size	CMD62(BOOT_SIZE_MULTI)	Boot Partition Size value
Set RPMB Partition Size	CMD62(RPMB_SIZE_MULTI)	RPMB Partition Size value F/W Re-Partition is executed in this step.
Power Cycle	•	•

Boot partition size is calculated as ( 128KB \* BOOT\_SIZE\_MULTI )

The size of Boot Area Partition 1 and 2 can not be set independently. It is set as same value.

RPMB partition size is calculated as ( 128KB \* RPMB\_SIZE\_MULTI ). In RPMB partition, CMD 0, 6, 8, 12, 13, 15, 18, 23, 25 are admitted.

Access Size of RPMB partition is defined as the below:

[Table 19] REL\_WR\_SEC\_C value for write operation on RPMB partition

REL_WR_SEC_C	Description
REL_WR_SEC_C = 1	Access sizes 256B and 512B supported to RPMB partition
REL_WR_SEC_C > 1	Access sizes up to REL_WR_SEC_C * 512B supported to RPMB partition with 256B granularity

Any undefined set of parameters or sequence of commands results in failure access.

If the failure is in data programming case, the data is not programmed. And if the failure occurs in data read case, the read data is '0x00'.

## 5.1.1.2 Enhanced Partition (Area)

SAMSUNG e·MMC adopts Enhanced User Data Area as SLC Mode. Therefore when master adopts some portion as enhanced user data area in User Data Area, that area occupies double size of original set up size. (ex> if master set 1MB for enhanced mode, total 2MB user data area is needed to generate 1MB enhanced area)

Max Enhanced User Data Area size is defined as (MAX\_ENH\_SIZE\_MULT x HC\_WP\_GRP\_SIZE x HC\_ERASE\_GRP\_SIZE x 512kBytes)



## 5.1.2 Write protect management

In order to allow the host to protect data against erase or write, the device shall support write protect commands.

#### 5.1.2.1 User Area Write Protection

TMP\_WRITE\_PROTECT (CSD[12]) and PERM\_WRITE\_PROTECT(CSD[13]) registers allow the host to apply write protection to whole device including Boot Partition, RPMB Partition and User Area.

[Table 20] whole device write protect priority

Class	Setting
Permanent write protect	SET : One time programmable
	CLR : Not available
Temporary write protect	SET : Multiple programmable
	CLR : Multiple programmable

USER\_WP (EXT\_CSD[171]) register allows the host to apply write protection to all the partitions in the user area.

[Table 21] User area write protect priority

Class	Setting
Permanent write protect	SET : One time programmable
r ermanent write protect	CLR : Not available
Power-on write protect	SET : One time programmable on power-on
	CLR : After power reset
Temporary write protect	SET : Multiple programmable
	CLR : Multiple programmable

The host has the ability to check the write protection status of segments by using the SEND\_WRITE\_PROT\_TYPE command (CMD31). When full card protection is enabled all the segments will be shown as having permanent protection.

### 5.1.2.2 Boot Partition Write Protection

BOOT\_WP (EXT\_CSD [173]) register allows the host to apply write protection to Boot Area Partitions.

[Table 22] Boot area write protect priority

Class	Setting
Permanent write protect	SET : One time programmable
	CLR : Not available
Power-on write protect	SET : One time programmable on power-on
1 ower-on write protect	CLR : After power reset

An attempt to set both the disable and enable bit for a given protection mode (permanent or power-on) in a single switch command will have no impact and switch error occurs.

Setting both B\_PERM\_WP\_EN and B\_PWR\_WP\_EN will result in the boot area being permanently protected.



## 5.1.3 Boot operation

Device supports not only boot mode but also alternative boot mode. Device supports high speed timing and dual data rate during boot

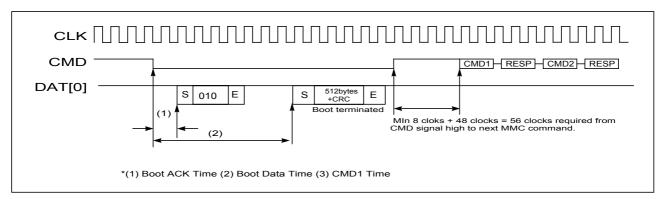


Figure 7. MultiMediaCard state diagram (boot mode)

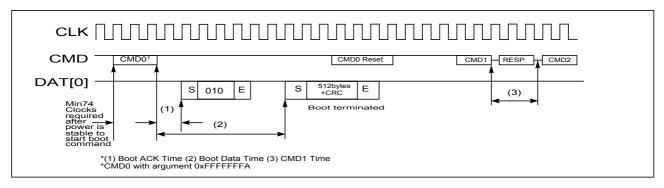


Figure 8. MultiMediaCard state diagram (alternative boot mode)

[Table 23] Boot ack, boot data and initialization Time

Timing Factor	Value
(1) Boot ACK Time	< 50 ms
(2) Boot Data Time	< 60 ms
(3) Initialization Time <sup>1)</sup>	< 3 secs

## NOTE:

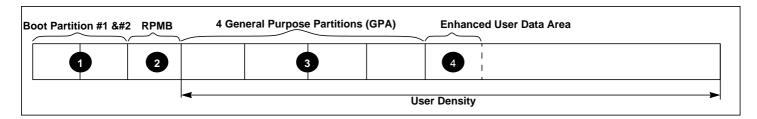
Minimum function for reading boot data is initialized during boot time and after that full function is initialized during initialization time.



<sup>1)</sup> This initialization time includes partition setting, Please refer to INI\_TIMEOUT\_AP in 6.4 Extended CSD Register. Normal initialization time (without partition setting) is completed within 1s (300ms for 4GB)

## 5.1.4 User Density

Total User Density depends on device type. For example, 32MB in the SLC Mode requires 96MB in TLC. This results in decreasing of user density



#### [Table 24] Capacity according to partition

	Boot partition 1	Boot partition 2	RPMB
Min.	2,048KB	2,048KB	128KB
Max.	4,096KB	4,096KB	4,096KB

## [Table 25] Maximum Enhanced Partition Size

Device	Max. Enhanced Partition Size
4 GB	1,302,331,392 Bytes
8 GB	2,605,711,360 Bytes
16 GB	5,209,325,568 Bytes
32 GB	10,418,651,136 Bytes
64 GB	20,837,302,272 Bytes

## [Table 26] User Density Size

Device	User Density Size
4 GB	3,909,091,328 Bytes
8 GB	7,818,182,656 Bytes
16 GB	15,634,268,160 Bytes
32 GB	31,268,536,320 Bytes
64 GB	62,537,072,640 Bytes



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## 5.1.5 Auto Power Saving Mode

If host does not issue any command during a certain duration (1ms), after previously issued command is completed, the device enters "Power Saving mode" to reduce power consumption.

At this time, commands arriving at the device while it is in power saving mode will be serviced in normal fashion

[Table 27] Auto Power Saving Mode enter and exit

Mode	Enter Condition	Escape Condition
I Auto Power Saving Mode	When previous operation which came from Host is completed and no command is issued during a certain time.	If Host issues any command

[Table 28] Auto Power Saving Mode and Sleep Mode

	Auto Power Saving Mode	Sleep Mode
NAND Power	ON	OFF
GotoSleep Time	< 1ms	< 1ms

## 5.1.6 Performance

[Table 29] Performance

Density	Sequential Read (MB/s)	Sequential Write (MB/s)
4 GB		7
8 GB		,
16 GB	71	11
32 GB		20
64 GB		20

<sup>\*</sup> Test Condition : Bus width x8, 50MHz DDR, 512KB data transfer, w/o file system overhead, measured on Samsung's internal board



# **6.0 REGISTER VALUE**

# 6.1 OCR Register

The 32-bit operation conditions register stores the VDD voltage profile of the e·MMC. In addition, this register includes a status information bit. This status bit is set if the e·MMC power up procedure has been finished. The OCR register shall be implemented by all e·MMCs.

### [Table 30] OCR Register

OCR bit	VDD voltage window <sup>2</sup>	Register Value
[6:0]	Reserved	00 00000b
[7]	1.70 - 1.95	1b
[14:8]	2.0-2.6	000 0000b
[23:15]	2.7-3.6	1 1111 1111b
[28:24]	Reserved	0 0000b
[30:29]	Access Mode	00b (byte mode) 10b (sector mode) -[ *Higher than 2GB only]
[31]		e·MMC power up status bit (busy)¹

#### NOTE:

- 1) This bit is set to LOW if the e·MMC has not finished the power up routine
- 2) The voltage for internal flash memory(VDDF) should be 2.7-3.6v regardless of OCR Register value.

# 6.2 CID Register

### [Table 31] CID Register

[ . aa.a a .] a.z . tag.ata.				
Name	Field	Width	CID-slice	CID Value
Manufacturer ID	MID	8	[127:120]	0x15
Reserved		6	[119:114]	
Card/BGA	CBX	2	[113:112]	01
OEM/Application ID	OID	8	[111:104]	1
Product name	PNM	48	[103:56]	See Product name table
Product revision	PRV	8	[55:48]	2
Product serial number	PSN	32	[47:16]	3
Manufacturing date	MDT	8	[15:8]	4
CRC7 checksum	CRC	7	[7:1]	5
not used, always '1'	-	1	[0:0]	

#### NOTE:

- 1),4),5) description are same as e.MMC JEDEC standard
- 2) PRV is composed of the revision count of controller and the revision count of F/W patch
- 3) A 32 bits unsigned binary integer. (Random Number)

## 6.2.1 Product name table (In CID Register)

## [Table 32] Product name

Part Number	Density	Product Name in CID Register (PNM)
KLM4G1YE4C-B001	4 GB	0 x 4D3447315943
KLM8G1WE4A-A001	8 GB	0 x 4D3847315741
KLMAG2WE4A-A001	16 GB	0 x 4D4147325741
KLMBG4WE4A-A001	32 GB	0 x 4D4247345741
KLMCG8WE4A-A001	64 GB	0 x 4D4347385741



# 6.3 CSD Register

The Card-Specific Data register provides information on how to access the e-MMC contents. The CSD defines the data format, error correction type, maximum data access time, data transfer speed, whether the DSR register can be used etc. The programmable part of the register (entries marked by W or E, see below) can be changed by CMD27. The type of the entries in the table below is coded as follows:

R: Read only

W: One time programmable and not readable.

R/W: One time programmable and readable.

W/E: Multiple writable with value kept after power failure, H/W reset assertion and any CMD0 reset and not readable.

R/W/E: Multiple writable with value kept after power failure, H/W reset assertion and any CMD0 reset and readable.

R/W/C\_P: Writable after value cleared by power failure and HW/ rest assertion (the value not cleared by CMD0 reset) and readable.

R/W/E\_P: Multiple writable with value reset after power failure, H/W reset assertion and any CMD0 reset and readable.

W/E/\_P: Multiple with blue reset after power failure, H/W reset assertion and any CMD0 reset and not readable.

### [Table 33] CSD Register

CSD structure	Name	Field	Width Cell		CSD-slice	CSD Value					
System specification version         SPEC_VERS         4         R         [125:122]         0x04           Reserved         -         2         R         [121:120]         -           Data read access-time 1         TAAC         8         R         [119:112]         0x27           Data read access-time 2 in CLK cycles (NSAC*100)         NSAC         8         R         [111:104]         0x01           Max. bus clock frequency         TRAN_SPEED         8         R         [103:96]         0x32           Card command classes         CCC         12         R         [95:84]         0x55           Max. read data block length         READ_BL_LEN         4         R         [83:80]         0x09           Partial blocks for read allowed         READ_BL_PARTIAL         1         R         [79:79]         0x00           Write block misalignment         WRITE_BLK_MISALIGN         1         R         [78:78]         0x00           Read block misalignment         READ_BLK_MISALIGN         1         R         [77:77]         0x00           DSR implemented         DSR_IMP         1         R         [76:76]         0x00           Reserved         -         2         R         [75:74] <t< th=""><th>Name</th><th>rieiu</th><th>Width</th><th>Туре</th><th>C3D-Slice</th><th>4GB</th><th>8GB</th><th>16GB</th><th>32GB</th><th>64GB</th></t<>	Name	rieiu	Width	Туре	C3D-Slice	4GB	8GB	16GB	32GB	64GB	
Reserved	CSD structure	CSD_STRUCTURE	2	R	[127:126]			0x03			
Data read access-time 1	System specification version	SPEC_VERS	4	R	[125:122]			0x04			
Data read access-time 2 in CLK cycles (NSAC*100)         NSAC         8         R         [111:104]         0x01           Max. bus clock frequency         TRAN_SPEED         8         R         [103:96]         0x32           Card command classes         CCC         12         R         [95:84]         0xF5           Max. read data block length         READ_BL_LEN         4         R         [83:80]         0x09           Partial blocks for read allowed         READ_BL_PARTIAL         1         R         [79:79]         0x00           Write block misalignment         WRITE_BLK_MISALIGN         1         R         [78:78]         0x00           Read block misalignment         READ_BLK_MISALIGN         1         R         [77:77]         0x00           DSR implemented         DSR_IMP         1         R         [76:76]         0x00           Reserved         -         2         R         [75:74]         -           Card size         C_SIZE         12         R         [73:62]         0xFFF           Max. read current @ VDD min         VDD_R_CURR_MAX         3         R         [58:56]         0x06           Max. write current @ VDD max         VDD_W_CURR_MAX         3         R         [5	Reserved	-	2	R	[121:120]			-			
Max. bus clock frequency         TRAN_SPEED         8         R         [103:96]         0x32           Card command classes         CCC         12         R         [95:84]         0xF5           Max. read data block length         READ_BL_LEN         4         R         [83:80]         0x09           Partial blocks for read allowed         READ_BL_PARTIAL         1         R         [79:79]         0x00           Write block misalignment         WRITE_BLK_MISALIGN         1         R         [78:78]         0x00           Read block misalignment         READ_BLK_MISALIGN         1         R         [77:77]         0x00           DSR implemented         DSR_IMP         1         R         [76:76]         0x00           Reserved         -         2         R         [75:74]         -           Card size         C_SIZE         12         R         [73:62]         0xFFF           Max. read current @ VDD min         VDD_R_CURR_MIN         3         R         [61:59]         0x06           Max. read current @ VDD max         VDD_W_CURR_MAX         3         R         [55:53]         0x06           Max. write current @ VDD max         VDD_W_CURR_MAX         3         R         [55:53]	Data read access-time 1	TAAC	8	R	[119:112]			0x27			
Card command classes         CCC         12         R         [95:84]         0xF5           Max. read data block length         READ_BL_LEN         4         R         [83:80]         0x09           Partial blocks for read allowed         READ_BL_PARTIAL         1         R         [79:79]         0x00           Write block misalignment         WRITE_BLK_MISALIGN         1         R         [78:78]         0x00           Read block misalignment         READ_BLK_MISALIGN         1         R         [77:77]         0x00           DSR implemented         DSR_IMP         1         R         [76:76]         0x00           Reserved         -         2         R         [75:74]         -           Card size         C_SIZE         12         R         [73:62]         0xFFF           Max. read current @ VDD min         VDD_R_CURR_MIN         3         R         [61:59]         0x06           Max. read current @ VDD max         VDD_W_CURR_MIN         3         R         [55:53]         0x06           Max. write current @ VDD min         VDD_W_CURR_MIN         3         R         [55:53]         0x06           Max. write current @ VDD max         VDD_W_CURR_MIX         3         R         [55:53]<	Data read access-time 2 in CLK cycles (NSAC*100)	NSAC	8	R	[111:104]			0x01			
Max. read data block length         READ_BL_LEN         4         R         [83:80]         0x09           Partial blocks for read allowed         READ_BL_PARTIAL         1         R         [79:79]         0x00           Write block misalignment         WRITE_BLK_MISALIGN         1         R         [78:78]         0x00           Read block misalignment         READ_BLK_MISALIGN         1         R         [77:77]         0x00           DSR implemented         DSR_IMP         1         R         [76:76]         0x00           Reserved         -         2         R         [75:74]         -           Card size         C_SIZE         12         R         [73:62]         0xFFF           Max. read current @ VDD min         VDD_R_CURR_MIN         3         R         [61:59]         0x06           Max. read current @ VDD max         VDD_R_CURR_MAX         3         R         [58:56]         0x06           Max. write current @ VDD min         VDD_W_CURR_MAX         3         R         [55:53]         0x06           Max. write current @ VDD max         VDD_W_CURR_MAX         3         R         [52:50]         0x06           Card size multiplier         C_SIZE_MULT         3         R         [	Max. bus clock frequency	TRAN_SPEED	8	R	[103:96]			0x32			
Partial blocks for read allowed         READ_BL_PARTIAL         1         R         [79:79]         0x00           Write block misalignment         WRITE_BLK_MISALIGN         1         R         [78:78]         0x00           Read block misalignment         READ_BLK_MISALIGN         1         R         [77:77]         0x00           DSR implemented         DSR_IMP         1         R         [76:76]         0x00           Reserved         -         2         R         [75:74]         -           Card size         C_SIZE         12         R         [73:62]         0xFFF           Max. read current @ VDD min         VDD_R_CURR_MIN         3         R         [61:59]         0x06           Max. write current @ VDD max         VDD_W_CURR_MAX         3         R         [55:53]         0x06           Max. write current @ VDD max         VDD_W_CURR_MAX         3         R         [55:53]         0x06           Max. write current @ VDD max         VDD_W_CURR_MAX         3         R         [52:50]         0x06           Card size multiplier         C_SIZE_MULT         3         R         [49:47]         0x07           Erase group size         ERASE_GRP_SIZE         5         R         [46:42]<	Card command classes	CCC	12	R	[95:84]			0xF5			
Write block misalignment         WRITE_BLK_MISALIGN         1         R         [78:78]         0x00           Read block misalignment         READ_BLK_MISALIGN         1         R         [77:77]         0x00           DSR implemented         DSR_IMP         1         R         [76:76]         0x00           Reserved         -         2         R         [75:74]         -           Card size         C_SIZE         12         R         [73:62]         0xFFF           Max. read current @ VDD min         VDD_R_CURR_MIN         3         R         [61:59]         0x06           Max. write current @ VDD max         VDD_W_CURR_MAX         3         R         [55:53]         0x06           Max. write current @ VDD max         VDD_W_CURR_MAX         3         R         [55:53]         0x06           Card size multiplier         C_SIZE_MULT         3         R         [49:47]         0x07           Erase group size         ERASE_GRP_SIZE         5         R         [46:42]         0x1F           Write protect group size         WP_GRP_SIZE         5         R         [36:32]         0x01         0x1F           Write protect group enable         WP_GRP_ENABLE         1         R	Max. read data block length	READ_BL_LEN	4	R	[83:80]			0x09			
Read block misalignment         READ_BLK_MISALIGN         1         R         [77:77]         0x00           DSR implemented         DSR_IMP         1         R         [76:76]         0x00           Reserved         -         2         R         [75:74]         -           Card size         C_SIZE         12         R         [73:62]         0xFFF           Max. read current @ VDD min         VDD_R_CURR_MIN         3         R         [61:59]         0x06           Max. read current @ VDD max         VDD_R_CURR_MAX         3         R         [58:56]         0x06           Max. write current @ VDD min         VDD_W_CURR_MIN         3         R         [55:53]         0x06           Max. write current @ VDD max         VDD_W_CURR_MAX         3         R         [52:50]         0x06           Card size multiplier         C_SIZE_MULT         3         R         [49:47]         0x07           Erase group size         ERASE_GRP_SIZE         5         R         [46:42]         0x1F           Write protect group size         WP_GRP_SIZE         5         R         [36:32]         0x01         0x1F           Write protect group enable         WP_GRP_ENABLE         1         R         [	Partial blocks for read allowed	READ_BL_PARTIAL	1	R	[79:79]			0x00			
DSR implemented         DSR_IMP         1         R         [76:76]         0x00           Reserved         -         2         R         [75:74]         -           Card size         C_SIZE         12         R         [73:62]         0xFFF           Max. read current @ VDD min         VDD_R_CURR_MIN         3         R         [61:59]         0x06           Max. read current @ VDD max         VDD_R_CURR_MAX         3         R         [58:56]         0x06           Max. write current @ VDD min         VDD_W_CURR_MIN         3         R         [55:53]         0x06           Max. write current @ VDD max         VDD_W_CURR_MAX         3         R         [52:50]         0x06           Card size multiplier         C_SIZE_MULT         3         R         [49:47]         0x07           Erase group size         ERASE_GRP_SIZE         5         R         [46:42]         0x1F           Write protect group size         WP_GRP_SIZE         5         R         [36:32]         0x01         0x1F           Write protect group enable         WP_GRP_ENABLE         1         R         [31:31]         0x01	Write block misalignment	WRITE_BLK_MISALIGN	1	R	[78:78]			0x00			
Reserved         -         2         R         [75:74]         -           Card size         C_SIZE         12         R         [73:62]         0xFFF           Max. read current @ VDD min         VDD_R_CURR_MIN         3         R         [61:59]         0x06           Max. read current @ VDD max         VDD_R_CURR_MAX         3         R         [58:56]         0x06           Max. write current @ VDD min         VDD_W_CURR_MIN         3         R         [55:53]         0x06           Max. write current @ VDD max         VDD_W_CURR_MAX         3         R         [52:50]         0x06           Card size multiplier         C_SIZE_MULT         3         R         [49:47]         0x07           Erase group size         ERASE_GRP_SIZE         5         R         [46:42]         0x1F           Write protect group size         WP_GRP_SIZE         5         R         [36:32]         0x01         0x1F           Write protect group enable         WP_GRP_ENABLE         1         R         [31:31]         0x01	Read block misalignment	READ_BLK_MISALIGN	1	R	[77:77]			0x00			
Card size         C_SIZE         12         R         [73:62]         0xFFF           Max. read current @ VDD min         VDD_R_CURR_MIN         3         R         [61:59]         0x06           Max. read current @ VDD max         VDD_R_CURR_MAX         3         R         [58:56]         0x06           Max. write current @ VDD min         VDD_W_CURR_MIN         3         R         [55:53]         0x06           Max. write current @ VDD max         VDD_W_CURR_MAX         3         R         [52:50]         0x06           Card size multiplier         C_SIZE_MULT         3         R         [49:47]         0x07           Erase group size         ERASE_GRP_SIZE         5         R         [46:42]         0x1F           Erase group size multiplier         ERASE_GRP_MULT         5         R         [41:37]         0x1F           Write protect group size         WP_GRP_SIZE         5         R         [36:32]         0x01         0x1F           Write protect group enable         WP_GRP_ENABLE         1         R         [31:31]         0x01	DSR implemented	DSR_IMP	1	R	[76:76]			0x00			
Max. read current @ VDD min         VDD_R_CURR_MIN         3         R         [61:59]         0x06           Max. read current @ VDD max         VDD_R_CURR_MAX         3         R         [58:56]         0x06           Max. write current @ VDD min         VDD_W_CURR_MIN         3         R         [55:53]         0x06           Max. write current @ VDD max         VDD_W_CURR_MAX         3         R         [52:50]         0x06           Card size multiplier         C_SIZE_MULT         3         R         [49:47]         0x07           Erase group size         ERASE_GRP_SIZE         5         R         [46:42]         0x1F           Erase group size multiplier         ERASE_GRP_MULT         5         R         [41:37]         0x1F           Write protect group size         WP_GRP_SIZE         5         R         [36:32]         0x01         0x1F           Write protect group enable         WP_GRP_ENABLE         1         R         [31:31]         0x01	Reserved	-	2	R	[75:74]			-			
Max. read current @ VDD max         VDD_R_CURR_MAX         3         R         [58:56]         0x06           Max. write current @ VDD min         VDD_W_CURR_MIN         3         R         [55:53]         0x06           Max. write current @ VDD max         VDD_W_CURR_MAX         3         R         [52:50]         0x06           Card size multiplier         C_SIZE_MULT         3         R         [49:47]         0x07           Erase group size         ERASE_GRP_SIZE         5         R         [46:42]         0x1F           Erase group size multiplier         ERASE_GRP_MULT         5         R         [41:37]         0x1F           Write protect group size         WP_GRP_SIZE         5         R         [36:32]         0x01         0x1F           Write protect group enable         WP_GRP_ENABLE         1         R         [31:31]         0x01	Card size	C_SIZE	12	R	[73:62]			0xFFF			
Max. write current @ VDD min         VDD_W_CURR_MIN         3         R         [55:53]         0x06           Max. write current @ VDD max         VDD_W_CURR_MAX         3         R         [52:50]         0x06           Card size multiplier         C_SIZE_MULT         3         R         [49:47]         0x07           Erase group size         ERASE_GRP_SIZE         5         R         [46:42]         0x1F           Erase group size multiplier         ERASE_GRP_MULT         5         R         [41:37]         0x1F           Write protect group size         WP_GRP_SIZE         5         R         [36:32]         0x01         0x1F           Write protect group enable         WP_GRP_ENABLE         1         R         [31:31]         0x01	Max. read current @ VDD min	VDD_R_CURR_MIN	3	R	[61:59]			0x06			
Max. write current @ VDD max         VDD_W_CURR_MAX         3         R         [52:50]         0x06           Card size multiplier         C_SIZE_MULT         3         R         [49:47]         0x07           Erase group size         ERASE_GRP_SIZE         5         R         [46:42]         0x1F           Erase group size multiplier         ERASE_GRP_MULT         5         R         [41:37]         0x1F           Write protect group size         WP_GRP_SIZE         5         R         [36:32]         0x01         0x1F           Write protect group enable         WP_GRP_ENABLE         1         R         [31:31]         0x01	Max. read current @ VDD max	VDD_R_CURR_MAX	3	R	[58:56]			0x06			
Card size multiplier         C_SIZE_MULT         3         R         [49:47]         0x07           Erase group size         ERASE_GRP_SIZE         5         R         [46:42]         0x1F           Erase group size multiplier         ERASE_GRP_MULT         5         R         [41:37]         0x1F           Write protect group size         WP_GRP_SIZE         5         R         [36:32]         0x01         0x1F           Write protect group enable         WP_GRP_ENABLE         1         R         [31:31]         0x01	Max. write current @ VDD min	VDD_W_CURR_MIN	3	R	[55:53]			0x06			
Erase group size         ERASE_GRP_SIZE         5         R         [46:42]         0x1F           Erase group size multiplier         ERASE_GRP_MULT         5         R         [41:37]         0x1F           Write protect group size         WP_GRP_SIZE         5         R         [36:32]         0x01         0x1F           Write protect group enable         WP_GRP_ENABLE         1         R         [31:31]         0x01	Max. write current @ VDD max	VDD_W_CURR_MAX	3	R	[52:50]			0x06			
Erase group size multiplier         ERASE_GRP_MULT         5         R         [41:37]         0x1F           Write protect group size         WP_GRP_SIZE         5         R         [36:32]         0x01         0x1F           Write protect group enable         WP_GRP_ENABLE         1         R         [31:31]         0x01	Card size multiplier	C_SIZE_MULT	3	R	[49:47]			0x07			
Write protect group size         WP_GRP_SIZE         5         R         [36:32]         0x01         0x1F           Write protect group enable         WP_GRP_ENABLE         1         R         [31:31]         0x01	Erase group size	ERASE_GRP_SIZE	5	R	[46:42]			0x1F			
Write protect group enable WP_GRP_ENABLE 1 R [31:31] 0x01	Erase group size multiplier	ERASE_GRP_MULT	5	R	[41:37]			0x1F			
	Write protect group size	WP_GRP_SIZE	5	R	[36:32]	0x	:01		0x1F		
Manufacturer default ECC DEFAULT ECC 2 R [30:29] 0v00	Write protect group enable	WP_GRP_ENABLE	1	R	[31:31]			0x01			
Manadada da d	Manufacturer default ECC	DEFAULT_ECC	2	R	[30:29]			0x00			
Write speed factor         R2W_FACTOR         3         R         [28:26]         0x03	Write speed factor	R2W_FACTOR	3	R	[28:26]			0x03			
Max. write data block length WRITE_BL_LEN 4 R [25:22] 0x09	Max. write data block length	WRITE_BL_LEN	4	R	[25:22]			0x09			
Partial blocks for write allowed WRITE_BL_PARTIAL 1 R [21:21] 0x00	Partial blocks for write allowed	WRITE_BL_PARTIAL	1	R	[21:21]			0x00			
Reserved - 4 R [20:17] -	Reserved	-	4	R	[20:17]			-			
Content protection application CONTENT_PROT_APP 1 R [16:16] 0x00	Content protection application	CONTENT_PROT_APP	1	R	[16:16]			0x00			
File format group FILE_FORMAT_GRP 1 R/W [15:15] 0x00	File format group	FILE_FORMAT_GRP	1	R/W	[15:15]			0x00			
Copy flag (OTP)	Copy flag (OTP)	COPY	1	R/W	[14:14]			0x01			
Permanent write protection PERM_WRITE_PROTECT 1 R/W [13:13] 0x00	Permanent write protection	PERM_WRITE_PROTECT	1	R/W	[13:13]			0x00			
Temporary write protection TMP_WRITE_PROTECT 1 R/W/E [12:12] 0x00	Temporary write protection	TMP_WRITE_PROTECT	1	R/W/E	[12:12]			0x00			
File format         FILE_FORMAT         2         R/W         [11:10]         0x00			2	R/W				0x00			
ECC code ECC 2 R/W/E [9:8] 0x00	ECC code	_	2	R/W/E				0x00			
CRC CRC 7 R/W/E [7:1] -	CRC	CRC	7	R/W/E				-			
Not used, always '1' - 1 - [0:0] -	Not used, always '1'	-	1	-				-			

IF THERE IS ANY OTHER OPERATION TO IMPLEMENT IN ADDITION TO SPECIFICATION IN THE DATASHEET OR JEDEC STANDARD, PLEASE CONTACT EACH BRANCH OFFICE OR HEADQUARTERS OF SAMSUNG ELECTRONICS.



# 6.4 Extended CSD Register

The Extended CSD register defines the e-MMC properties and selected modes. It is 512 bytes long.

The most significant 320 bytes are the Properties segment, which defines the e-MMC capabilities and cannot be modified by the host. The lower 192 bytes are the Modes segment, which defines the configuration the e-MMC is working in. These modes can be changed by the host by means of the SWITCH command.

R: Read only

W: One time programmable and not readable.

R/W: One time programmable and readable.

W/E: Multiple writable with value kept after power failure, H/W reset assertion and any CMD0 reset and not readable.

R/W/E: Multiple writable with value kept after power failure, H/W reset assertion and any CMD0 reset and readable.

R/W/C\_P: Writable after value cleared by power failure and HW/ rest assertion (the value not cleared by CMD0 reset) and readable.

 $R/W/E\_P: \\ \text{Multiple writable with value reset after power failure, } H/W \text{ reset assertion and any CMD0 reset and readable.}$ 

W/E/ P: Multiple with blue reset after power failure, H/W reset assertion and any CMD0 reset and not readable

### [Table 34] Extended CSD Register

Name	Field	Size	Cell	CSD-slice CSD Value					а		
Name	rieiu	(Bytes)	Type	C3D-Slice	4GB	8GB	16GB	32GB	64GE		
	Properties	s Segment									
Reserved <sup>1</sup>		7	-	[511:505]			-				
Supported Command Sets	S_CMD_SET	1	R	[504]		0x01					
HPI features	HPI_FEATURES	1	R	[503]		0x03					
Background operations support	BKOPS_SUPPORT	1	R	[502]		0x01					
Reserved <sup>1</sup>		254	-	[501:248]			-				
Power off notification(long) timeout	POWER_OFF_LONG_TIME	1	R	[247]	Don'	t care		0x3C			
Background operations status	BKOPS_STATUS	1	R	[246]			0x00				
Number of correctly programmed sectors	CORRECTLY_PRG_SECT ORS_NUM	4	R	[245:242]			0x00				
I st initialization time after partitioning	INI_TIMEOUT_AP	1	R	[241]	0x1E						
Reserved <sup>1</sup>	•	1	-	[240]			-				
Power class for 52MHz, DDR at 3.6V	PWR_CL_DDR_52_360	1	R	[239]	0x00						
Power class for 52MHz, DDR at 1.95V	PWR_CL_DDR_52_195	1	R	[238]	0x00						
Reserved <sup>1</sup>	•	2	-	[237:236]	-						
Minimum Write Performance for 8 bit at 52MHz in DDR mode	MIN_PERF_DDR_W_8_52	1	R	[235]			0x00				
Minimum Read Performance for 8 bit at 52MHz in DDR mode	MIN_PERF_DDR_R_8_52	1	R	[234]	0x00						
Reserved <sup>1</sup>	•	1	-	[233]			-				
TRIM Multiplier	TRIM_MULT	1	R	[232]			0x02				
Secure Feature support	SEC_FEATURE_SUPPORT	1	R	[231]			0x15				
Secure Erase Multiplier	SEC_ERASE_MULT	1	R	[230]			0x1B				
Secure TRIM Multiplier	SEC_TRIM_MULT	1	R	[229]			0x11				
Boot information	BOOT_INFO	1	R	[228]			0x07				
Reserved <sup>1</sup>		1	-	[227]			-				
Boot partition size	BOOT_SIZE_MULTI	1	R	[226]			0x10				
Access size	ACC_SIZE	1	R	[225]	0x	05		0x07			
High-capacity erase unit size	HC_ERASE_GRP_SIZE	1	R	[224]			0x01				
High-capacity erase timeout	ERASE_TIMEOUT_MULT	1	R	[223]			0x01				
Reliable write sector count	REL_WR_SEC_C	1	R	[222]			0x01				
High-capacity write protect group size	HC_WP_GRP_SIZE	1	R	[221]	0x	:02		0x30			
Sleep current (VDDF)	S_C_VDDF	1	R	[220]			0x07				
Sleep current (VDD)	S_C_VDD	1	R	[219]			0x07				
Reserved <sup>1</sup>		1	-	[218]			-				
Sleep/awake timeout	S_A_TIMEOUT	1	R	[217]			0x11				

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# datasheet

# KLMxGxxE4x-x001

Reserved <sup>1</sup>		1	-	[216]			-		
Sector Count	SEC_COUNT	4	R	[215:212]	0x748 000	0xE90 000	0x1D1 F000	0x3A3 E000	0x747 C000
Reserved <sup>1</sup>		1	-	[211]			-		
Minimum Write Performance for 8bit @52MHz	MIN_PERF_W_8_52	1	R	[210]			0x00		
Minimum Read Performance for 8bit @52MHz	MIN_PERF_R_8_52	1	R	[209]			0x00		
Minimum Write Performance for 8bit @26MHz /4bit @52MHz	MIN_PERF_W_8_26_4_52	1	R	[208]			0x00		
Minimum Read Performance for 8bit @26MHz /4bit @52MHz	MIN_PERF_R_8_26_4_52	1	R	[207]			0x00		
Minimum Write Performance for 4bit @26MHz	MIN_PERF_W_4_26	1	R	[206]			0x00		
Minimum Read Performance for 4bit @26MHz	MIN_PERF_R_4_26	1	R	[205]			0x00		
Reserved <sup>1</sup>		1	-	[204]			-		
Power Class for 26MHz @ 3.6V	PWR_CL_26_360	1	R	[203]			0x00		
Power Class for 52MHz @ 3.6V	PWR_CL_52_360	1	R	[202]			0x00		
Power Class for 26MHz @ 1.95V	PWR_CL_26_195	1	R	[201]			0x00		
Power Class for 52MHz @ 1.95V	PWR_CL_52_195	1	R	[200]			0x00		
Partition switching timing	PARTITION_SWITCH_ TIME	1	R	[199]			0x01		
Out-of-interrupt busy timing	OUT_OF_INTERRUPT_ TIME	1	R	[198]			0x02		
Reserved <sup>1</sup>		1	-	[197]			-		
Card Type	CARD_TYPE	1	R	[196]			0x07		
Reserved <sup>1</sup>		1	-	[195]			-		
CSD Structure Version	CSD_STRUCTURE	1	R	[194]			0x02		
Reserved <sup>1</sup>		1	-	[193]			-		
Extended CSD Revision	EXT_CSD_REV	1	R	[192]			0x05		
	Modes	Segment							
Command Set	CMD_SET	1	R/W/ E_P	[191]			0x00		
Reserved <sup>1</sup>		1	-	[190]			-		
Command Set Revision	CMD_SET_REV	1	R	[189]			0x00		
Reserved <sup>1</sup>		1	-	[188]			-		
Power Class	POWER_CLASS	1	R/W/ E_P	[187]			0x00		
Reserved <sup>1</sup>		1	-	[186]			-		
High Speed Interface Timing	HS_TIMING	1	R/W/ E_P	[185]			0x00		
Reserved <sup>1</sup>		1	_	[184]			-		
Bus Width Mode	BUS_WIDTH	1	W/E_P	[183]			0x00		
Reserved <sup>1</sup>	_	1	-	[182]			_		
Erased Memory Content	ERASED_MEM_CONT	1	R	[181]			0x00		
Reserved <sup>1</sup>		1	-	[180]			-		
Partition configurationn	PARTITION_CONFIG	1	R/W/E& R/W/ E_P	[179]			0x00		
Boot config proteetion	BOOT_CONFIG_PRPT	1	R/W & R/W/ C_P	[178]			0x00		

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# datasheet

# KLMxGxxE4x-x001

Boot bus width1	BOOT_BUS_WIDTH	1	R/W/E	[177]		0x00
Reserved <sup>1</sup>		1	-	[176]		-
		•	R/W/			
High-density erase group definition	ERASE_GROUP_DEF	1	E_P	[175]		0x00
Reserved <sup>1</sup>		1	-	[174]		-
Boot area write proection register	BOOT_WP	1	R/W & R/W/ C_P	[173]		0x00
Reserved <sup>1</sup>		1	-	[172]		-
User area write protection register	USER_WP	1	R/W, R/W/ C_P& R/W/ E_P	[171]		0x00
Reserved <sup>1</sup>		1	-	[170]		-
FW configuration	FW_CONFIG	1	R/W	[169]		0x00
RPMB Size	RPMB_SIZE_MULT	1	R	[168]		0x01
Write reliability setting register	WR_REL_SET	1	R/W	[167]		0x1F
Write reliability parameter register	WR_REL_PARAM	1	R	[166]		0x05
Reserved <sup>1</sup>		1	-	[165]		-
Manually start background operations	BKOPS_START	1	W/E_P	[164]		0x00
Enable background operations handshake	BKOPS_EN	1	R/W	[163]		0x00
H/W reset function	RST_n_FUNCTION	1	R/W	[162]		0x00
HPI management	HPI_MGMT	1	R/W/ E_P	[161]		0x00
Partitoning support	RARTITIONING_SUPPORT	1	R	[160]		0x03
Max Enhanced Area Size	MAX_ENH_SIZE_MULT	3	R	[159:157]	0x4DA 0x9B5	0xCF 0x19E 0x33C
Partitions attribute	PARTITIONS_ATTRIBUTE	1	R/W	[156]		0x00
Paritioning Setting	PARTITION_SETTING_CO MPLETED	1	R/W	[155]		0x00
General Purpose Partition Size	GP_SIZE_MULT	12	R/W	[154:143]		0x00
Enhanced User Data Area Size	ENH_SIZE_MULT	3	R/W	[142:140]		0x00
Enhanced User Data Start Address	ENH_START_ADDR	4	R/W	[139:136]		0x00
Reserved <sup>1</sup>		1	-	[135]		-
Bad Block Management mode	SEC_BAD_BLK_MGMT	1	R/W	[134]		0x00
Reserved <sup>1</sup>		6	-	[133:128]		-
Vendor Config	VENDOR_CONFIG	60	-	[127:68]	ı	Don't care
Vendor Config (Auto Background Operation)	AUTO_BKOPS	1	R/W/E	[67]	1	Don't care
Vendor Config (Aligned Optimal Trim/Discard Size)	ALIGNED_OPTIMAL_ TRIM_DISCARD_SIZE	1	R	[66]		0x08
Vendor Config (Optimized Features)	OPTIMIZED_FEATURES	2	R	[65:64]		0x03
Reserved <sup>1</sup>		29	-	[63:35]		-
Power Off Notification	POWER_OFF_NOTIFICATI ON	1	R/W/ E_P	[34]	Don't care	0x00
Reserved <sup>1</sup>	1	34	-	[33:0]		-

NOTE:

1) Reserved bits should be read as "0."



# 7.0 AC PARAMETER

## 7.1 Time Parameter

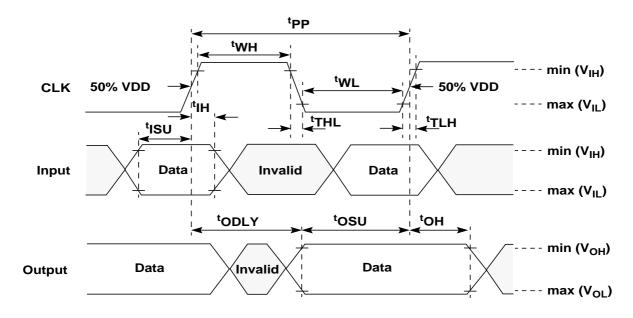
[Table 35] Time Parameter

Tir	ning Paramter	Max. Value	Unit
Initialization Time (tINIT)	Normal <sup>1)</sup>	1 (300ms for 4GB)	s
, ,	After partition setting <sup>2)</sup>	3	S
Read Timeout		100	ms
Write Timeout		350	ms
Erase Timeout		15	ms
Force Erase Timeout		3	min
Secure Erase Timeout		8	S
Secure Trim step1 Timeout		5	S
Secure Trim step2 Timeout		3	S
Trim Timeout 3)		600	ms
Partition Switching Timeout (aft	er Init)	100	us
Power Off Notification Timeout	4)	600	ms
Discard Timeout		15	ms

#### NOTE:

- 1) Normal Initialization Time without partition setting
  2) Initialization Time after partition setting, refer to INI\_TIMEOUT\_AP in 6.4 EXT\_CSD register
- 3) If 8KB Size and Address are aligned, Max. Timeout value is 300ms
- 4) Power Off Notification is not implemented for 4,8GB products

# 7.2 Bus Timing Parameter



Data must always be sampled on the rising edge of the clock.

Figure 9. Bus signal levels



#### [Table 36] Default (under 26MHz)

Parameter	Symbol	Min	Max	Unit	Remark <sup>1</sup>					
Clock CL	Clock CLK(All values are referred to $\min(V_{IH})$ and $\max(V_{IL})^2$									
Clock frequency Data Transfer Mode3	fPP	04	26	MHz	CL <= 30 pF Tolerance: +100KHz					
Clock frequency Identification Mode	f <sub>OD</sub>	04	400	kHz	Tolerance: +20KHz					
Clock low time	t <sub>WL</sub>	10		ns	C <sub>L</sub> <= 30 pF					
Clock high time	t <sub>WH</sub>	10								
Clock rise time <sup>5</sup>	t <sub>TLH</sub>		10	ns	C <sub>L</sub> <= 30 pF					
Clock fall time	t <sub>THL</sub>		10	ns	C <sub>L</sub> <= 30 pF					
	Inputs CMD, DA	T (referenced t	o CLK)							
Input set-up time	t <sub>ISU</sub>	3		ns	C <sub>L</sub> <= 30 pF					
Input hold time	t <sub>IH</sub>	3		ns	C <sub>L</sub> <= 30 pF					
	Outputs CMD, DAT (referenced to CLK)									
Output hold time	t <sub>OH</sub>	8.3		ns	CL <= 30 pF					
Output set-up time	t <sub>osu</sub>	11.7		ns	CL <= 30 pF					

#### NOTE:

- 1)The card must always start with the backward-compatible interface timing mode can be switched to high-speed interface timing by the host sending the SWITCH command (CMD6) with the argument for high-speed interface select.
- 2) CLK timing is measured at 50% of VDD.
- 3) For compatibility with cards that suport the v4.2 standard or earlier verison, host should not use>20MHz before switching to high-speed interface timing.
- 4) Frequency is periodically sampled and is not 100% tested.
- 5) CLK rise and fall times are measured by  $min(V_{IH})$  and  $max(V_{IL})$ .

### [Table 37] High-Speed Mode

Parameter	Symbol	Min	Max	Unit	Remark
Clock CL	K(All values are refe	erred to min(V <sub>IH</sub>	) and max(V <sub>IL</sub> ) <sup>1</sup>		
Clock frequency Data Transfer Mode <sup>2</sup>	f <sub>PP</sub>	03	52 <sup>4)</sup>	MHz	C <sub>L</sub> <= 30 pF
Clock frequency Identification Mode	f <sub>OD</sub>	03	400	kHz	CL <= 30 pF
Clock low time	t <sub>WL</sub>	6.5		ns	C <sub>L</sub> <= 30 pF
Clock High time	t <sub>WH</sub>	6.5		ns	C <sub>L</sub> <= 30 pF
Clock rise time <sup>5</sup>	t <sub>TLH</sub>		3	ns	C <sub>L</sub> <= 30 pF
Clock fall time	t <sub>THL</sub>		3	ns	C <sub>L</sub> <= 30 pF
	Inputs CMD, DAT	(referenced to	CLK)		
Input set-up time	t <sub>ISU</sub>	3		ns	C <sub>L</sub> <= 30 pF
Input hold time	t <sub>IH</sub>	3		ns	C <sub>L</sub> <= 30 pF
	Outputs CMD, DAT	(referenced to	CLK)		
Output Delay time during Data Transfer Mode	t <sub>ODLY</sub>		13.7	ns	CL <= 30 pF
Output hold time	t <sub>OH</sub>	2.5			C <sub>L</sub> <= 30 pF
Signal rise time	t <sub>RISE</sub>		3	ns	C <sub>L</sub> <= 30 pF
Signal fall time	t <sub>FALL</sub>		3	ns	C <sub>L</sub> <= 30 pF

- 1) CLK timing is measured at 50% of VDD.
- 2) A MultiMediaCard shall support the full frequency range from 0-26MHz, or 0-52MHz
- 3) Frequency is periodically sampled and is not 100% tested.
- 4) Card can operate as high-speed card interface timing at 26MHz clock frequency.

  5) CLK rise and fall times are measured by min(V<sub>IH</sub>) and max(V<sub>IL</sub>), and outputs CMD, DAT rise and fall times are measured by min(V<sub>IH</sub>) and max(V<sub>IL</sub>), and outputs CMD, DAT rise and fall times are measured by  $min(V_{OH})$  and  $max(V_{OL})$ .



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# 7.3 Bus timing for DAT signals during 2x data rate operation

These timings applies to the DAT[7:0] signals only when the device is configured for dual data mode operation. In this dual data mode, the DAT signals operates synchronously of both the rising and the falling edges of CLK. The CMD signal still operates synchronously of the rising edge of CLK and there fore it complies with the bus timing specified in chapter 7.2, Therefore there is no timing change for the CMD signal

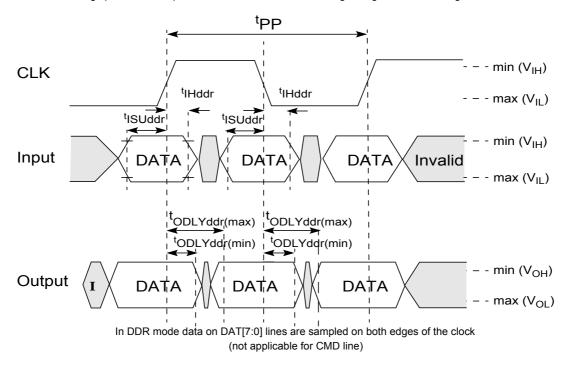


Figure 10. Timing diagram: data input/output in dual data rate mode

## 7.3.1 Dual data rate interface timings

[Table 38] High-speed dual rate interface timing

Parameter	Symbol	Min	Max.	Unit	Remark <sup>1</sup>					
	Input CLK <sup>1</sup>									
Clock duty cycle		45	55	%	Includes jitter, phase noise					
	Input DAT (referenced to CLK-DDR mode)									
Input set-up time	tISUddr	2.5		ns	CL ≤ 20 pF					
Input hold time	tlHddr	2.5		ns	CL ≤ 20 pF					
	Output DAT (refe	erenced to CLK-D	DDR mode)							
Output delay time during data transfer	tODLYddr	1.5	7	ns	CL ≤ 20 pF					
Signal rise time (all signals) <sup>2</sup>	tRISE		2	ns	CL ≤ 20 pF					
Signal fall time (all signals)	tFALL		2	ns	CL ≤ 20 pF					

## NOTE:

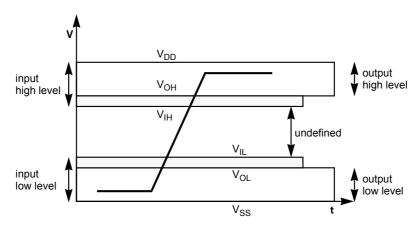
1) CLK timing is measuted at 50% of VDD

2) Inputs CMD, DAT rise and fall times are measured by min  $(V_{IH})$  and max $(V_{IL})$ , and outputs CMD, DAT rise and fall times measured by min  $(V_{OH})$  and max $(V_{OL})$ 



# 7.4 Bus signal levels

As the bus can be supplied with a variable supply voltage, all signal levels are related to the supply voltage.



## 7.4.1 Open-drain mode bus signal level

[Table 39] Open-drain bus signal level

Parameter	Symbol	Min	Max.	Unit	Conditions
Output HIGH voltage	V <sub>OH</sub>	V <sub>DD</sub> - 0.2		V	I <sub>OH</sub> = -100 uA
Output LOW voltage	V <sub>OL</sub>		0.3	V	I <sub>OL</sub> = 2 mA

The input levels are identical with the push-pull mode bus signal levels.

### 7.4.2 Push-pull mode bus signal level.high-voltage MultiMediaCard

To meet the requirements of the JEDEC standard JESD8C.01, the card input and output voltages shall be within the following specified ranges for any  $V_{DD}$  of the allowed voltage range:

[Table 40] Push-pull signal level.high-voltage MultiMediaCard

Parameter	Symbol	Min	Max.	Unit	Conditions
Output HIGH voltage	V <sub>OH</sub>	0.75*V <sub>DD</sub>		V	I <sub>OH</sub> = -100 uA@V <sub>DD</sub> min
Output LOW voltage	V <sub>OL</sub>		0.125*V <sub>DD</sub>	V	I <sub>OL</sub> = 100 uA@V <sub>DD</sub> min
Input HIGH voltage	V <sub>IH</sub>	0.625*V <sub>DD</sub>	V <sub>DD</sub> + 0.3	V	
Input LOW voltage	V <sub>IL</sub>	V <sub>SS</sub> - 0.3	0.25*V <sub>DD</sub>	V	

## 7.4.3 Push-pull mode bus signal level.dual-voltage MultiMediaCard

The definition of the I/O signal levels for the Dual voltage MultiMediaCard changes as a function of V<sub>DD</sub>.

- 2.7V 3.6V: Identical to the High Voltage MultiMediaCard (refer to Chapter 7.4.2 on page29 above).
- 1.95V 2.7V: Undefined. The card is not operating at this voltage range.
- 1.70V 1.95V: Compatible with EIA/JEDEC Standard "EIA/JESD8-7 Normal Range" as defined in the following table.

[Table 41] Push-pull signal level—dual-voltage MultiMediaCard

Parameter	Symbol	Min	Max.	Unit	Conditions
Output HIGH voltage	V <sub>OH</sub>	V <sub>DD</sub> - 0.45V		V	I <sub>OH</sub> = -2mA
Output LOW voltage	V <sub>OL</sub>		0.45V	V	I <sub>OL</sub> = 2mA
Input HIGH voltage	V <sub>IH</sub>	0.65*V <sub>DD</sub> <sup>1)</sup>	V <sub>DD</sub> + 0.3	V	
Input LOW voltage	V <sub>IL</sub>	V <sub>SS</sub> - 0.3	0.35*V <sub>DD</sub> <sup>2)</sup>	V	

# NOTE:

- 1) 0.7\*V<sub>DD</sub> for MMC4.3 and older revisions.
- 2)  $0.3*V_{DD}$  for MMC4.3 and older revisions.



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## 7.4.4 Push-pull mode bus signal level.e·MMC

The definition of the I/O signal levels for the e·MMC devices changes as a function of VCCQ.

- 2.7V-3.6: Identical to the High Voltage MultiMediaCard (refer to Chapter 7.4.2 on page29).
- 1.95- 2.7V: Undefined. The e MMCdevice is not operating at this voltage range.
- 1.65V-1.95V: Identical to the 1.8V range for the Dual Voltage MultiMediaCard (refer to Chapter 7.4.3 on page29).
- 1.3V 1.65V: Undefined. The e·MMC device is not operating at this voltage range.
- 1.1V-1.3V: Compatible with EIA/JEDEC Standard "JESD8-12A.01 normal range: as defined in the following table.

[Table 42] Push-pull signal level.1.1V-1.3V VCCQ range e·MMC

Parameter	Symbol	Min	Max.	Unit	Conditions
Output HIGH voltage	V <sub>OH</sub>	0.75V <sub>CCQ</sub>		V	I <sub>OH</sub> = -2mA
Output LOW voltage	V <sub>OL</sub>		0.25V <sub>CCQ</sub>	V	I <sub>OL</sub> = 2mA
Input HIGH voltage	V <sub>IH</sub>	0.65*V <sub>CCQ</sub>	V <sub>CCQ</sub> + 0.3	V	
Input LOW voltage	V <sub>IL</sub>	V <sub>SS</sub> - 0.3	0.35*V <sub>CCQ</sub>	V	



# 8.0 DC PARAMETER

# 8.1 Active Power Consumption during operation

[Table 43] Active Power Consumption during operation

Density	NAND Type	CTRL	NAND	Unit	
4GB	32Gb TLC x 1		50		
8GB	64Gb TLC x 1		50		
16GB	64Gb TLC x 2	100	100	mA	
32GB	64Gb TLC x 4		200		
64GB	64Gb TLC x 8		200		

<sup>\*</sup> Power Measurement conditions: Bus configuration =x8 @52MHz

# 8.2 Standby Power Consumption in auto power saving mode and standby state

[Table 44] Standby Power Consumption in auto power saving mode and standby state

Density	NAND Type	CTRL		CTRL NAND		Unit
Delisity	NAND Type	25°C(Typ)	85°C	25°C(Typ)	85°C	Oille
4GB	32Gb TLC x 1			40	85	
8GB	64Gb TLC x 1	100		40	03	
16GB	64Gb TLC x 2		250	50	135	uA
32GB	64Gb TLC x 4			70	235	
64GB	64Gb TLC x 8			130	435	

#### NOTE:

Power Measurement conditions: Bus configuration =x8 , No CLK

# 8.3 Sleep Power Consumption in Sleep State

[Table 45] Sleep Power Consumption in Sleep State

Density	NAND Type	CTRL		NAND	Unit	
Delisity	NAND Type	25°C(Typ)	85°C	NAND	O III	
4GB	32Gb TLC x 1					
8GB	64Gb TLC x 1					
16GB	64Gb TLC x 2	100	250	0 <sup>1)</sup>	uA	
32GB	64Gb TLC x 4					
64GB	64Gb TLC x 8	1				

## NOTE:

Power Measurement conditions: Bus configuration =x8 , No CLK

# 8.4 Supply Voltage

[Table 46] Supply Voltage

Item	Min	Max	Unit
VDD	1.70 (2.7)	1.95 (3.6)	V
VDDF	2.7	3.6	V
Vss	-0.5	0.5	V

# 8.5 Bus Operating Conditions

[Table 47] Bus Operating Conditions

Parameter	Min Max		Unit
Peak voltage on all lines	-0.5	3.6	V
Input Leakage Current	-2	2	μΑ
Output Leakage Current	-2	2	μΑ



<sup>\*</sup> The measurement for max RMS current is the average RMS current consumption over a period of 100ms.

<sup>\*</sup>Typical value is measured at Vcc=3.3V, TA=25°C. Not 100% tested.

<sup>1)</sup> In auto power saving mode, NAND power can not be turned off. However in sleep mode NAND power can be turned off. If NAND power is alive, NAND power is same with that of the Standby state.

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# 8.6 Bus Signal Line Load

The total capacitance  $C_L$  of each line of the e·MMC bus is the sum of the bus master capacitance  $C_{HOST}$ , the bus capacitance  $C_{BUS}$  itself and the capacitance  $C_{movi}$  of the e·MMC connected to this line:

The sum of the host and bus capacitances should be under 20pF.

[Table 48] Bus Signal Line Load

Parameter	Symbol	Min	Тур.	Max	Unit	Remark
Pull-up resistance for CMD	R <sub>CMD</sub>	4.7		100	KOhm	to prevent bus floating
Pull-up resistance for DAT0-DAT7	R <sub>DAT</sub>	10		100	KOhm	to prevent bus floating
Internal pull up resistance DAT1-DAT7	R <sub>int</sub>	10		150	KOhm	to prevent unconnected lines floating
Single e·MMC capacitance	C <sub>BGA</sub>		7	12	pF	
Maximum signal line inductance				16	nH	f <sub>PP</sub> <= 52 MHz

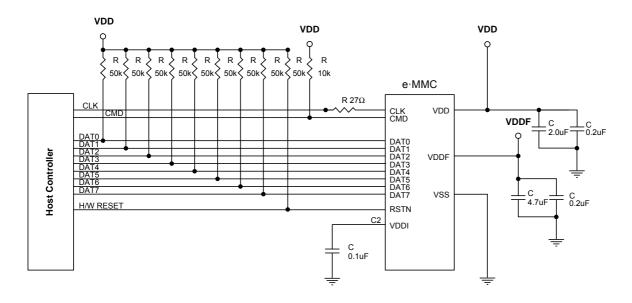


# A. e-MMC Connection Guide

This Connection guide is an example for customers to adopt e·MMC more easily

- This appendix is just guideline for e-MMC connection. This value and schematic can be changed depending on the system environment.
- Coupling capacitor should be connected with VDD and VSS as closely as possible.
- VDDI Capacitor is min 0.1uF
- Impedance on CLK match is needed.
- SAMSUNG recommends 27 $\Omega$  for resistance on CLK line. However  $0\Omega$  ~47 $\Omega$  is also available.
- ullet If host does not have a plan to use H/W reset, it is not needed to put 50K $\Omega$  pull-up resistance on H/W rest line.
- SMASUNG Recommends to separate VDD and VDDF power.

# A.1 x8 support Host connection Guide



# A.2 x4 support Host connection Guide

